

**Search Notes**

Application/Control No.

10/676,795

Examiner

Stephen W. Smoot

Applicant(s)/Patent under  
Reexamination

RICHARDS ET AL.

Art Unit

2813

**SEARCHED**

Class	Subclass	Date	Examiner
257	295	1/7/2005	SWS
257	310	1/7/2005	SWS
257	534	1/7/2005	SWS
257	535	1/7/2005	SWS
438	3	1/7/2005	SWS

*S.W.S.***INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Key Words: Memory Cell - FRAM, FeRAM; Ferroelectric Polymer - Polyvinylidene Fluoride, Trifluoroethylene;	1/7/2005	<i>S.W.S.</i> SWS
Interface Material - Titanium Oxide; Electrode - Aluminum, Titanium.	1/7/2005	<i>S.W.S.</i> SWS
Search Tools - EAST (attached): USPAT; US PG PUBS; Derwent; EPO; JPO; IBM TDB	1/7/2005	<i>S.W.S.</i> SWS